


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517623	<b>Applicant(s)/Patent Under Reexamination</b>  YABE ET AL.
	<b>Examiner</b>  Kim, Hee Soo	<b>Art Unit</b>  2457

SEARCHED			
Class	Subclass	Date	Examiner
709	206	1/7/2009	HSK

SEARCH NOTES		
Search Notes	Date	Examiner
Updated East Search	1/7/2009	HSK
Mustafa Meky Allowance Ok'ed and Search Help	1/7/2009	HSK
Alex Wang Search Help	1/7/2009	HSK
EIC Search	1/8/2009	HSK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	206	1/7/2009	HSK

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